



Photocoupler Product Data Sheet

LTV-074L

Spec No.: DS70-2014-0019

Effective Date: 06/07/2016

Revision: A

LITE-ON DCC

RELEASE

BNS-OD-FC001/A4

Photocoupler LTV-074L series

1. DESCRIPTION

The LTV-074L consists of a high efficient AlGaAs Light Emitting Diode and a high speed optical detector. This design provides excellent AC and DC isolation between the input and output sides of the Optocoupler. The output of the optical detector features a totem pole output. The internal shield ensures high common mode transient immunity. A guaranteed common mode transient immunity is up to 10KV/ μ s. The Optocoupler operational parameters are guaranteed over the temperature range from -40°C to +105°C.

1.1 Features

- Dual channel High speed 15MBd
- 3.3V and 5.5V CMOS Compatible
- Available in SO8.
- Safety approval

UL 1577

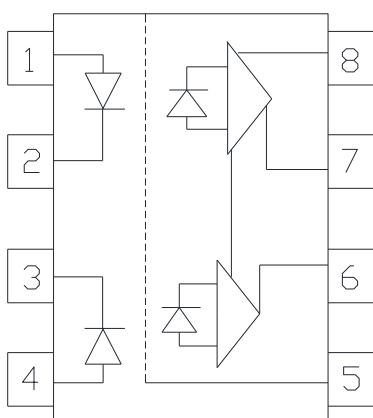
VDE DIN/EN 60747-5-5

- RoHS Compliance

1.2 Applications

- High Voltage Isolation
- Isolation in line receivers
- Ground loop elimination
- Feedback Element in Switching Mode Power Supplier
- Data transmission
- CANBus, RS485, USB
- Interface between Microprocessor system, computer and their peripheral

1.3 Functional Diagram



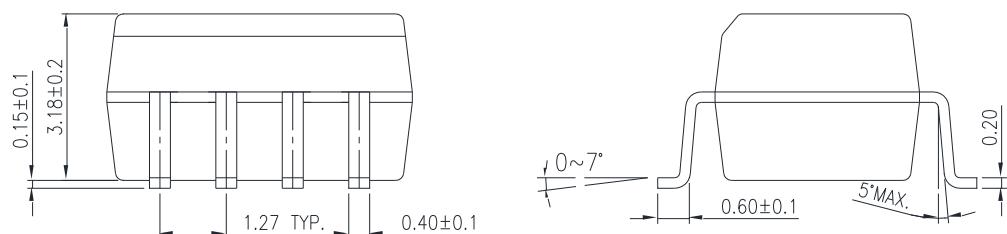
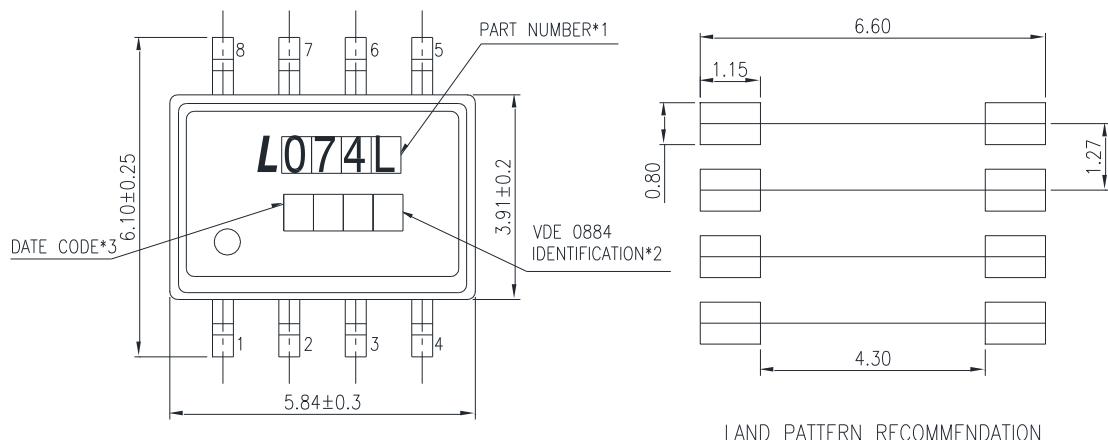
Truth Table (Positive Logic)

LED	OUT
ON	L
OFF	H

A 0.1 μ F bypass Capacitor must be connected between Pin8 and Pin5

Photocoupler LTV-074L series

2. PACKAGE DIMENSIONS



Part No : LTV-074L

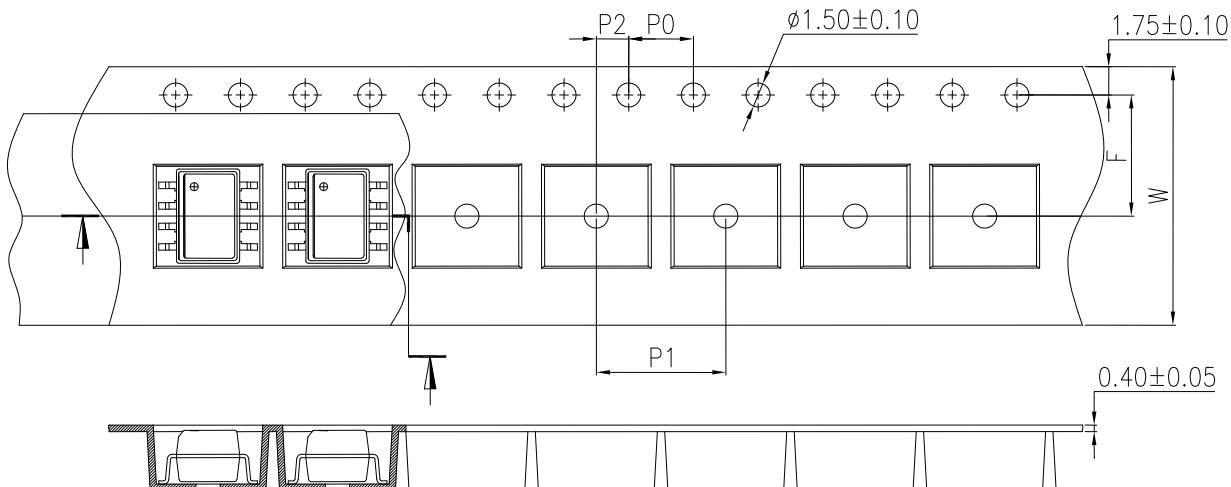
Notes :

1. Part numbers
 2. "V" to represent VDE0884
 3. The first digit is year code, second and third digit is week code
- *. Dimensions are all in Millimeters.

Photocoupler LTV-074L series

3. TAPING DIMENSIONS

3.1 LTV-074L



Description	Symbol	Dimension in mm (inch)
Tape wide	W	16±0.3 (0.63)
Pitch of sprocket holes	P ₀	4±0.1 (0.15)
Distance of compartment	F	7.5±0.1 (0.295)
	P ₂	2±0.1 (0.079)
Distance of compartment to compartment	P ₁	12±0.1 (0.47)

3.2 Quantities Per Reel

Package Type	LTV-074L
Quantities (pcs)	2000

Photocoupler
LTV-074L series

4. RATING AND CHARACTERISTICS

4.1 Absolute Maximum Ratings at Ta=25°C *

	Parameter	Symbol	Rating	Unit	Note
Input	Average Forward Input Current	I _F	20	mA/ch	2
	Reverse Input Voltage	V _R	5	V	
Output	Output Collector Current	I _O	10	mA	
	Output Collector Voltage	V _O	7	V	
	Output Collector Power Dissipation	P _O	60	mW	
	Isolation Voltage	V _{iso}	3750	V _{rms}	
	Supply Voltage	V _{CC}	7	V	
	Operating Temperature	T _{opr}	-40 ~ +105	°C	
	Storage Temperature	T _{stg}	-55 ~ +125	°C	
	Lead Solder Temperature **	T _{sol}	260	°C	

*Ambient temperature = 25°C, unless otherwise specified. Stresses exceeding the absolute maximum ratings can cause permanent damage to the device. Exposure to absolute maximum ratings for long periods of time can adversely affect reliability.

**260°C for 10 seconds. Refer to Lead Free Reflow Profile.

4.2 Recommended Operation Condition

Parameter	Symbol	Min.	Max.	Units
Ambient Operation Temperature	T _A	-40	+105	°C
Supply Voltage	V _{CC}	4.5	5.5	V
		3.0	3.6	V
Input Current (ON)	I _F	9	16	mA

Photocoupler
LTV-074L series

 4.3 ELECTRICAL OPTICAL CHARACTERISTICS at $T_a=25^\circ C$

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition	Note
Input							
Input Forward Voltage	V_F	1.3	1.55	1.80	V	$I_F = 14mA$	
Input Forward Voltage Temperature Coefficient	$\Delta V_F / \Delta T$	—	-1.143	—	mV/ $^\circ C$	$I_F = 14mA$	
Input Reverse Voltage	BV_R	5.0	—	—	V	$I_R = 10\mu A$	
Input Threshold Current	I_{TH}	—	6	11	mA	$V_O < 0.8V$	
Input Capacitance	C_{IN}	—	34	—	pF	$f = 1MHz, V_F = 0V$	
Detector							
High Level Supply Current	I_{CCH}	—	—	16	mA	$I_F = 0mA$	1
Low Level Supply Current	I_{CCL}	—	—	16	mA	$I_F = 14mA$	1
High Level Output Current	V_{OH}	2.3	—	—	V	$V_{CC} = 3.3V, I_O = -4mA, I_F = 0mA$	
		4.5	—	—		$V_{CC} = 5V, I_O = -4mA, I_F = 0mA$	
Low Level Output Voltage	V_{OL}	—	—	0.80	V	$V_{CC} = 3.3V, I_O = 4mA, I_F = 14mA$	
		—	—	0.80		$V_{CC} = 5V, I_O = 4mA, I_F = 14mA,$	

Specified over recommended temperature ($T_A = -40^\circ C$ to $+105^\circ C$) unless otherwise specified.

Typical values applies to $V_{CC} = 5V, T_A = 25^\circ C$.

Photocoupler
LTV-074L series

5. SWITCHING SPECIFICATION

$T_A=0\sim70^\circ C$, $V_{CC}=5V$, unless otherwise specified.

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition	Note
Propagation Delay Time to Low Output Level *4	t_{PHL}	—	—	60	ns	$I_F=14mA$, $C_L = 15pF$, $V_{CC}=3.3V$	4
		—	—	60		$I_F=14mA$, $C_L = 15pF$, $V_{CC}=5V$	
Propagation Delay Time to High Output Level *3	t_{PLH}	—	—	60	ns	$I_F=14mA$, $C_L = 15pF$, $V_{CC}=3.3V$	3
		—	—	60		$I_F=14mA$, $C_L = 15pF$, $V_{CC}=5V$	
Pulse Width Distortion	$ t_{PLH} - t_{PHL} $	—	—	30	ns	$I_F=14mA$, $C_L = 15pF$, $V_{CC}=3.3V$	
		—	—	30		$I_F=14mA$, $C_L = 15pF$, $V_{CC}=5V$	
Propagation Delay Skew	t_{PSK}			40		$C_L = 15pF$, $V_{CC}=5V$	
Output Rise Time (10 to 90%)	t_r	—	8	—		$I_F=14mA$, $C_L = 15pF$, $V_{CC}=5V$	
Output Fall Time (90 to 10%)	t_f	—	6	—			
Pulse width	t_{PW}	66.7	—	—		—	
Common Mode Transient Immunity at	$ CM_H $	10	—	—	kV/ μ s	$ V_{CM} = 1KV$, $V_{CC} = 5V$, $I_F = 0mA$, $V_O > 3V$, $T_A = 25^\circ C$	5
Common Mode Transient Immunity at	$ CM_L $	10	—	—	kV/ μ s	$ V_{CM} = 1KV$, $V_{CC} = 5V$, $I_F = 14mA$, $V_O < 0.8V$, $T_A = 25^\circ C$	6

Specified over recommended temperature ($T_A = -40^\circ C$ to $+105^\circ C$) unless otherwise specified. Typical values applies to $T_A = 25^\circ C$

Photocoupler
LTV-074L series

6. ISOLATION CHARACTERISTIC

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition	Note
Input-Output Insulation Leakage Current	I _{I-O}	—	—	1.0	μA	45% RH, t = 5s, V _{I-O} = 3kV DC, T _A = 25°C	7
Withstand Insulation Test Voltage	V _{ISO}	3750	—	—	V _{RMS}	RH ≤ 50%, t = 1min, T _A = 25°C	7
Input-Output Resistance	R _{I-O}	—	10 ¹²	—	Ω	V _{I-O} = 1KV DC	7
Input-Output Capacitance	C _{I-O}	—	0.6	—	pF	f = 1MHz, T _A = 25°C	7

Specified over recommended temperature (T_A = -40°C to +105°C) unless otherwise specified. Typical values applies to T_A = 25°C

Photocoupler LTV-074L series

7. SWITCHING TIME TEST CIRCUIT

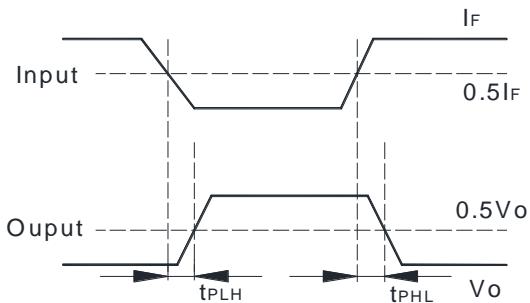
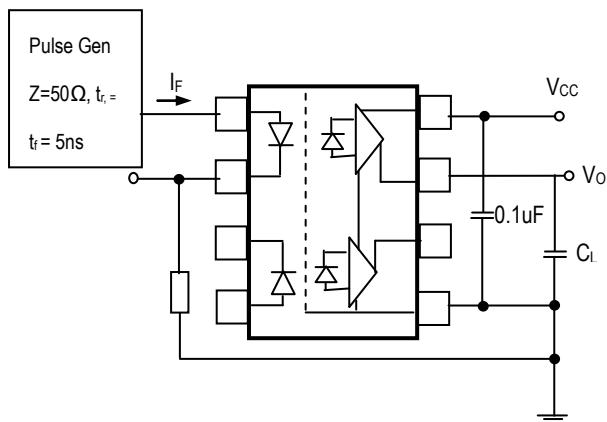


Figure 1: Two Channel Test Circuit for t_{PHL} and t_{PLH}

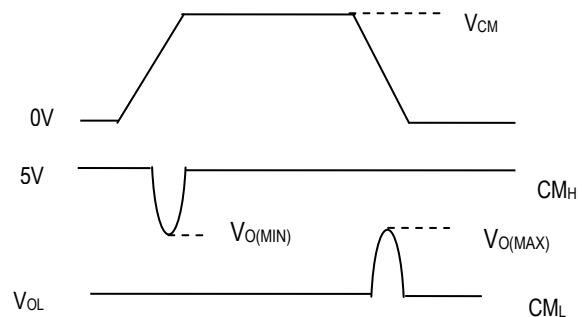
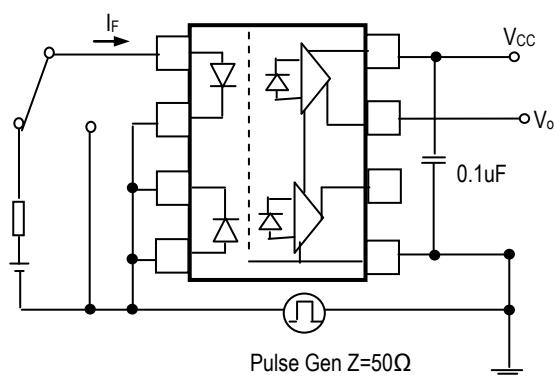


Figure 2: Two Channel Test Circuit for Common Mode Transient Immunity

Photocoupler LTV-074L series

8. TYPICAL PERFORMANCE CURVES

Figure 3: Input Current vs Forward Voltage

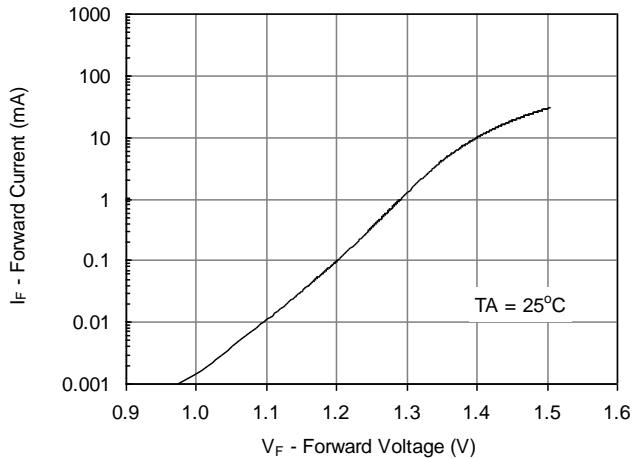


Figure 5: Supply Current High vs Temperature

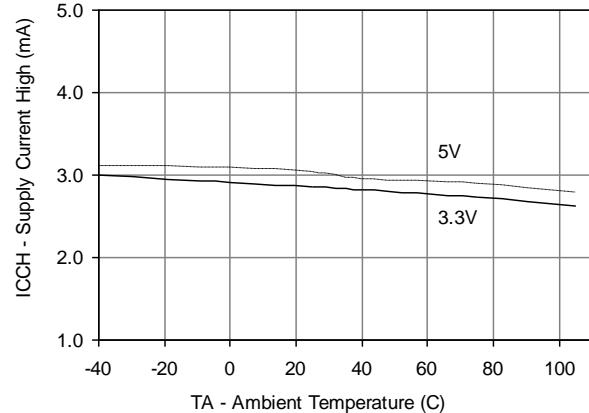


Figure 7: Switching Speed vs Input Current at 5V

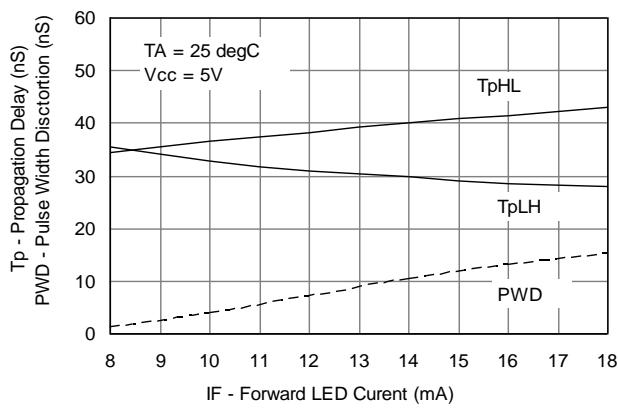


Figure 4: Forward Voltage vs Temperature

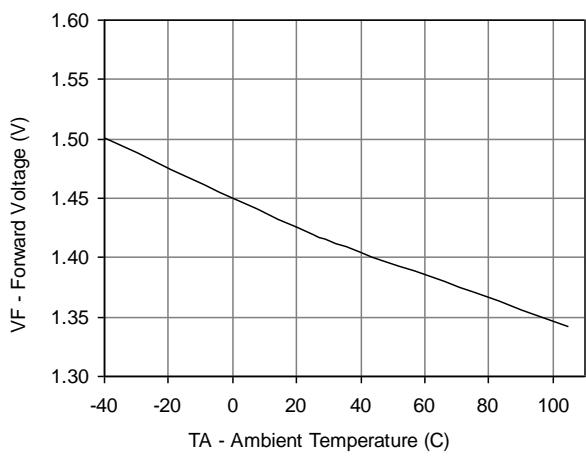


Figure 6: Supply Current Low vs Supply Voltage

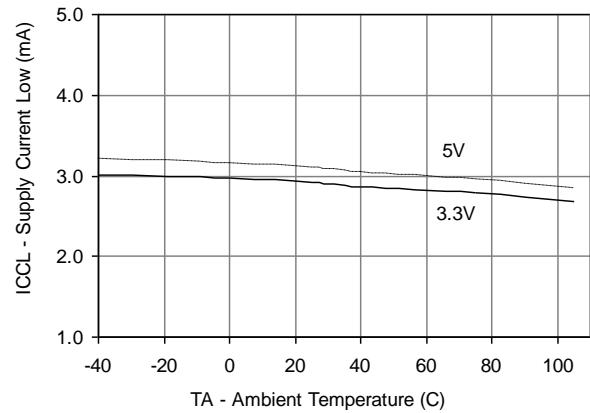
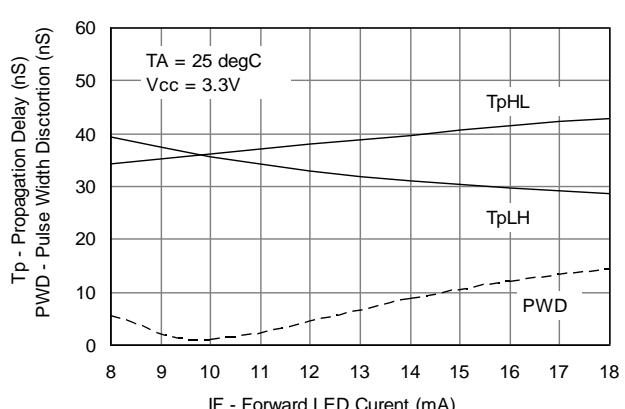


Figure 8: Switching Speed vs Input Current at 3.3V





LITEON®
OPTOELECTRONICS

Data Sheet

Photocoupler
LTV-074L series

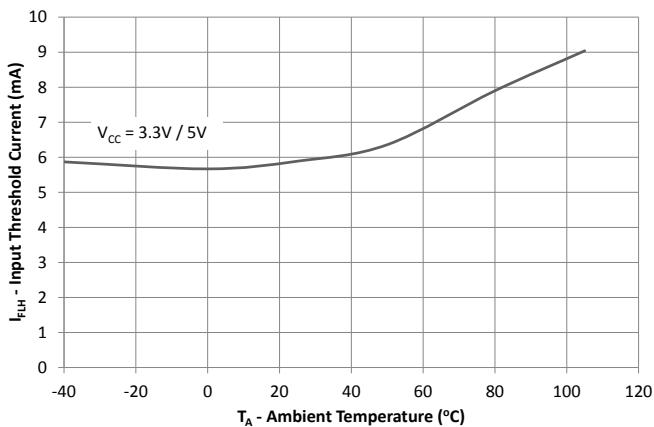


Figure 9: Input Threshold Current vs Temperature

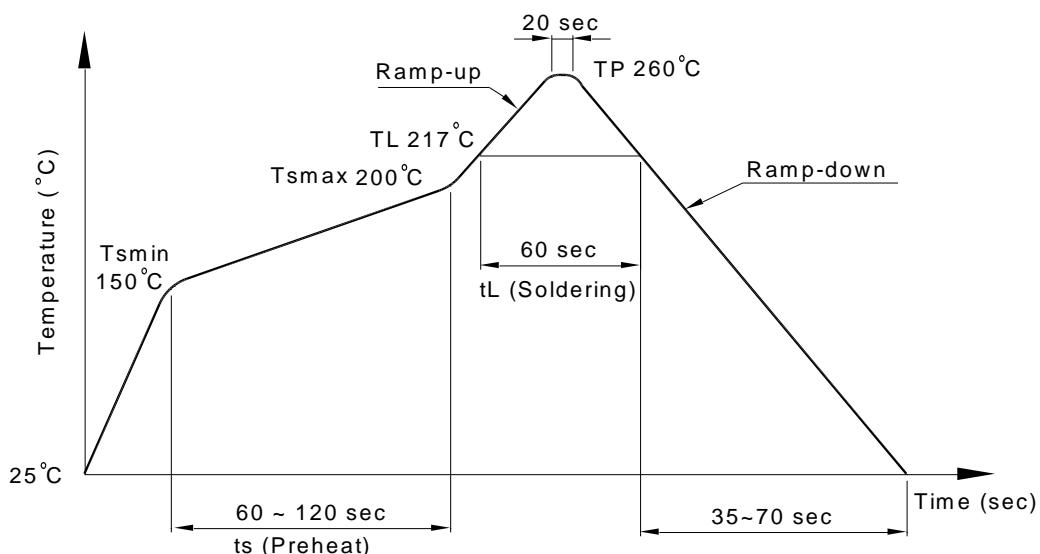
Photocoupler LTV-074L series

9. TEMPERATURE PROFILE OF SOLDERING

9.1 IR Reflow soldering (JEDEC-STD-020 compliant)

One time soldering reflow is recommended within the condition of temperature and time profile shown below. Do not solder more than three times.

Profile item	Conditions
Preheat	
- Temperature Min (T_{Smin})	150°C
- Temperature Max (T_{Smax})	200°C
- Time (min to max) (t_s)	90±30 sec
Soldering zone	
- Temperature (T_L)	217°C
- Time (t_L)	60 sec
Peak Temperature (T_P)	260°C
Ramp-up rate	3°C / sec max.
Ramp-down rate	3~6°C / sec



Photocoupler LTV-074L series

9.2 Wave soldering (JEDEC22A111 compliant)

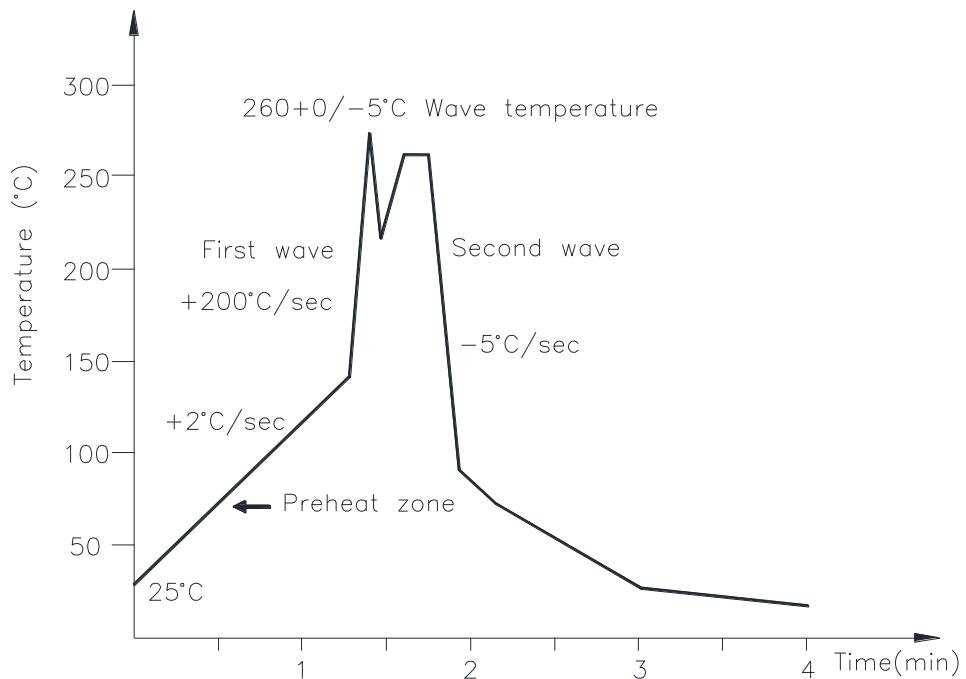
One time soldering is recommended within the condition of temperature.

Temperature: $260+0/-5^{\circ}\text{C}$

Time: 10 sec.

Preheat temperature: 25 to 140°C

Preheat time: 30 to 80 sec.



9.3 Hand soldering by soldering iron

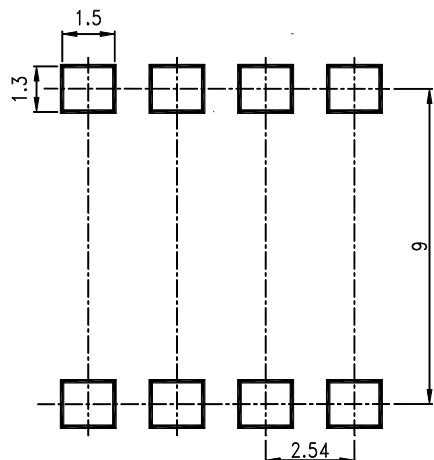
Allow single lead soldering in every single process. One time soldering is recommended.

Temperature: $380+0/-5^{\circ}\text{C}$

Time: 3 sec max.

Photocoupler LTV-074L series

10. RECOMMENDED FOOT PRINT PATTERNS (MOUNT PAD)



Note :

Dimensions in millimeters.

11. NOTES

LiteOn is continually improving the quality, reliability, function or design and LiteOn reserves the right to make changes without further notices.

The products shown in this publication are designed for the general use in electronic applications such as office automation equipment, communications devices, audio/visual equipment, electrical application and instrumentation.

For equipment/devices where high reliability or safety is required, such as space applications, nuclear power control equipment, medical equipment, etc, please contact our sales representatives.

When requiring a device for any "specific" application, please contact our sales in advice.

If there are any questions about the contents of this publication, please contact us at your convenience.

The contents described herein are subject to change without prior notice.

Immerge unit's body in solder paste is not recommended.

1. A 0.1 μ F or bigger bypass capacitor for V_{CC} is needed as shown in Fig.1
2. Peaking driving circuit may be used to speed up the LED. The peak drive current of LED may go up to 50mA and maximum pulse width 50ns, as long as average current doesn't exceed 20mA.
3. t_{PLH} (propagation delay) is measured from the 6.5 mA point on the falling edge of the input pulse to the 1.5 V point on the rising edge of the output pulse.
4. t_{PHL} (propagation delay) is measured from the 6.5 mA point on the rising edge of the input pulse to the 1.5 V point on the falling edge of the output pulse.

Photocoupler **LTV-074L series**

5. $|CM_H|$ is the maximum tolerable rate of rise of the common mode voltage to assure that the output will remain in a high logic state (i.e., $V_O > 3.0$ V).
6. $|CM_L|$ is the maximum tolerable rate of fall of the common mode voltage to assure that the output will remain in a low logic state (i.e., $V_O < 0.8$ V).
7. Device is considered a two-terminal device: pins 1, 2, 3, and 4 shorted together, and pins 5, 6, 7, and 8 shorted together.